

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/799,434	WESCHLER, RICHARD	
Examiner	Art Unit	
IOHN PAK	1616	

	SEARCHED				
Class	Subclass	Date	Examiner		
424	76.5,76.8 76.9,600 618,619 630,637 641,646	8/05)		
	641,646 647,725 742,774		m		
514 502	699 770 84,406		/ //		
502	84,406 517	1			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST-PGPB, USPT, JPAB, ANDI See printent	7/05	M		
STN - HCaplus, WPIDS, CABA, BIOSIS Reg See printont	7/05	9D		
WEST-PGPB, USPT, JPAB, DWPI See Printant	8/05	M		
STN - Environment Cluster See Printant	8/05	m		
Used STIC NPL site \$ Used SCirus, Proquest, Adricola to search (Landfill and Fuller's earth)	8/05	D		